## Application/Control No. Applicant(s)/Patent Under Reexamination 10/723,806 COMPTON ET AL. Notice of References Cited Examiner **Art Unit** Page 1 of 1 **David Lee** 2633 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 359/124 US-2003/0002099 A1 01-2003 Sayyah et al. Α 398/98 В US-6,519,067 B2 02-2003 Farhan et al. С US-D US-US-Ε

## **FOREIGN PATENT DOCUMENTS**

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